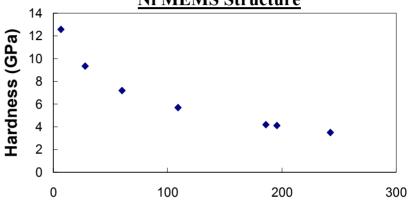
Fatigue of LIGA Ni MEMS Structures

Wolé Soboyejo, Princeton Materials Institute, Princeton University, DMR Award#0075135

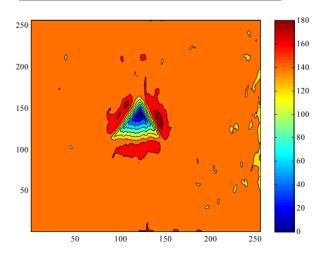
- Significant progress in the study of nanoindentation size effects in LIGA Ni MEMS structures
- Size effects modeled using mechanisms-based strain gradient plasticity theory
- Pile-up phenomena (associated with indentation experiment)
- Fatigue micro-tester designed and built in the past year
 - J. Lou, P. Shrotriya, S. Allameh, N. Yao, T. Buchheit, and W.O. Soboyejo, "Plasticity Length Scale in LIGA Nickel MEMS Structure" (Paper B2.5), 2001 Fall Meeting Symposium B, Volume 687 (Ranked No.3 in Most Downloaded Online Proceedings Papers for the year of 2002 Jan-April 206 downloads)
 - P. Shrotriya, S.M. Allameh, J. Lou, T. Bucheit and W.O. Soboyejo, "On the Measurement of the Plasticity Length-Scale Parameter in LIGA Nickel Foils", Mechanics and Materials Journal, 2001. (In Press)
 - J. Lou, P. Shrotriya, T. Buchheit, D. Yang and W.O. Soboyejo, "A Nano-Indentation Study of Plasticity Length Scale Effects in LIGA Ni MEMS Structures", Journal of Materials Research (Submitted)

Size-Dependence of Hardness in LIGA Ni MEMS Structure



Residual Depth (nm)

Pile-up Across Nano-Indentation



Fatigue of LIGA Ni MEMS Structures

Wolé Soboyejo, Princeton Materials Institute, Princeton University, DMR Award#0075135

Brief Summary of Outreach Activities

- Focus on under-represented minorities and women
- Organized two workshops for minority high school students to introduce materials science
- 2 minority students hired to work in the summer of 2001
 - Adler Perotte (length-scale effects)
 - Seye Tairu (microstructural characterization)
- 1 female graduate student
 - Verna Lomax

Deposited Pd Layer

- 1 male graduate student
 - Jun Lou (passed PhD general exam)
- Post-doctoral researcher (Pranav Shrotriya) and Staff Scientist (Seyed Allameh) have participated in research
- Developed new graduate course on MEMS
 - co-taught with Dr. Azzam Yassen of Orchid Bioscience

Fatigue Micro-Tester



FIB Image of Microstructure of LIGA
Ni MEMS (Cross-section)

